



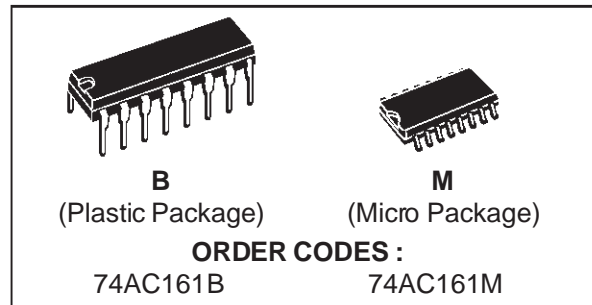
SYNCHRONOUS PRESETTABLE 4-BIT COUNTER

- HIGH SPEED:
 $f_{MAX} = 125 \text{ MHz (TYP.) at } V_{CC} = 5\text{V}$
- LOW POWER DISSIPATION:
 $I_{CC} = 8 \mu\text{A (MAX.) at } T_A = 25 \text{ }^\circ\text{C}$
- HIGH NOISE IMMUNITY:
 $V_{NIH} = V_{NIL} = 28\% V_{CC} \text{ (MIN.)}$
- 50Ω TRANSMISSION LINE DRIVING CAPABILITY
- SYMMETRICAL OUTPUT IMPEDANCE:
 $|I_{OH}| = I_{OL} = 24 \text{ mA (MIN)}$
- BALANCED PROPAGATION DELAYS:
 $t_{PLH} \equiv t_{PHL}$
- OPERATING VOLTAGE RANGE:
 $V_{CC} \text{ (OPR)} = 2\text{V to } 6\text{V}$
- PIN AND FUNCTION COMPATIBLE WITH 74 SERIES 161
- IMPROVED LATCH-UP IMMUNITY

DESCRIPTION

The AC161 is a high-speed CMOS SYNCHRONOUS PRESETTABLE COUNTER fabricated with sub-micron silicon gate and double-layer metal wiring C²MOS technology. It is ideal for low power applications maintaining high speed operation similar to equivalent Bipolar Schottky TTL. It is a 4 bit binary counter with Asynchronous Clear.

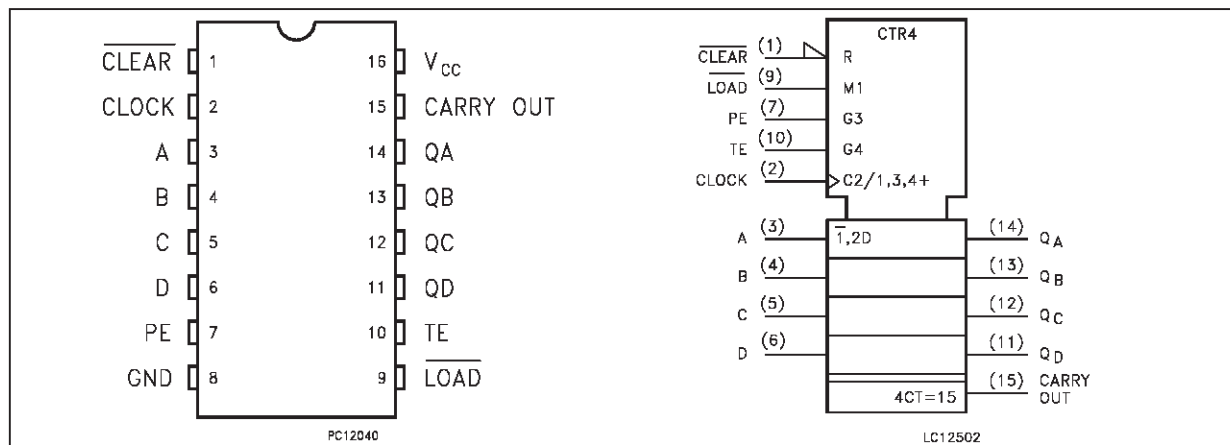
The circuit have four fundamental modes of operation, in order of preference: synchronous



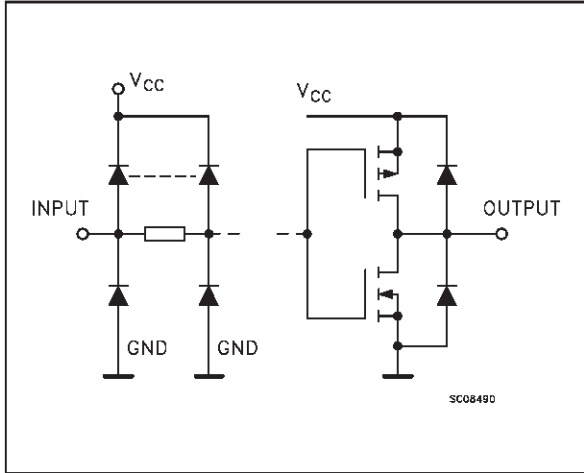
reset, parallel load, count-up and hold. Four control inputs, Master Reset (CLEAR), Parallel Enable Input (LOAD), Count Enable Input (PE) and Count Enable Carry Input (TE), determine the mode of operation as shown in the Truth Table. A LOW signal on CLEAR overrides counting and parallel loading and sets all outputs on LOW state. A LOW signal on LOAD overrides counting and allows information on Parallel Data Q_n inputs to be loaded into the flip-flops on the next rising edge of CLOCK. With LOAD and CLEAR, PE and TE permit counting when both are HIGH. Conversely, a LOW signal on either PE and TE inhibits counting.

All inputs and outputs are equipped with protection circuits against static discharge, giving them 2KV ESD immunity and transient excess voltage.

PIN CONNECTION AND IEC LOGIC SYMBOLS



INPUT AND OUTPUT EQUIVALENT CIRCUIT



PIN DESCRIPTION

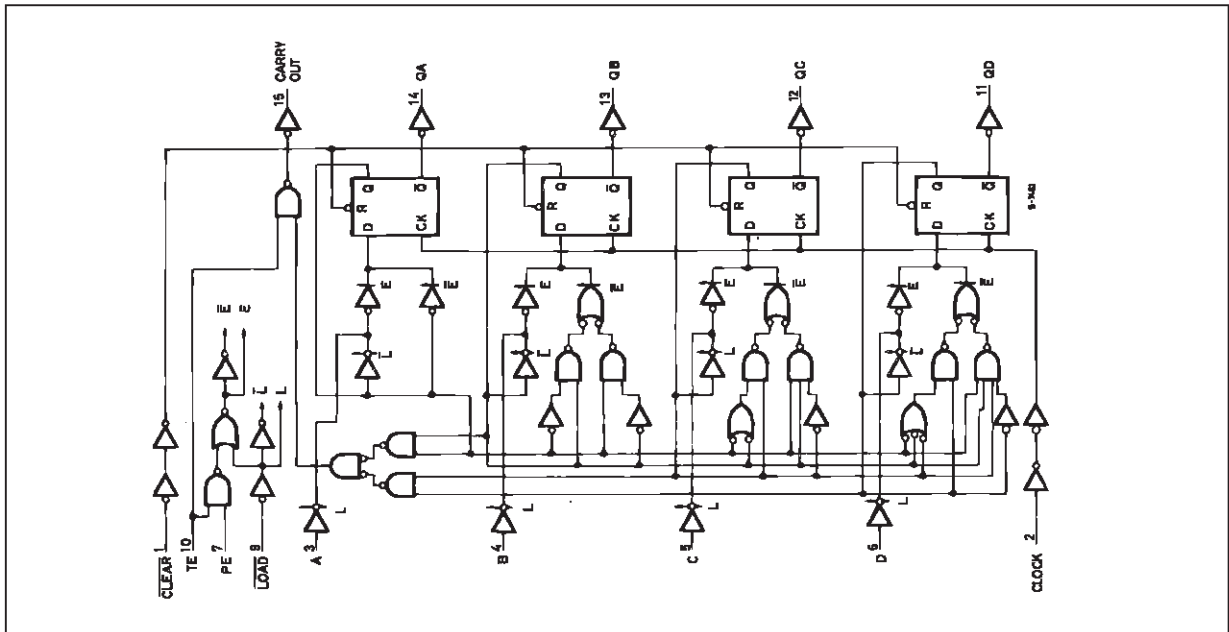
| PIN No | SYMBOL | NAME AND FUNCTION |
|----------------|---------------------------|--|
| 1 | $\overline{\text{CLEAR}}$ | Master Reset |
| 2 | CLOCK | Clock Input (LOW-to-HIGH, Edge- Triggered) |
| 3, 4, 5, 6 | A, B, C, D | Data Inputs |
| 7 | PE | Count Enable Input |
| 10 | $\overline{\text{TE}}$ | Count Enable Carry Input |
| 9 | $\overline{\text{LOAD}}$ | Parallel Enable Input |
| 14, 13, 12, 11 | QA to QD | Flip-Flop Output |
| 15 | CARRY OUT | Terminal Count Output |
| 8 | GND | Ground (0V) |
| 16 | V _{CC} | Positive Supply Voltage |

TRUTH TABLE

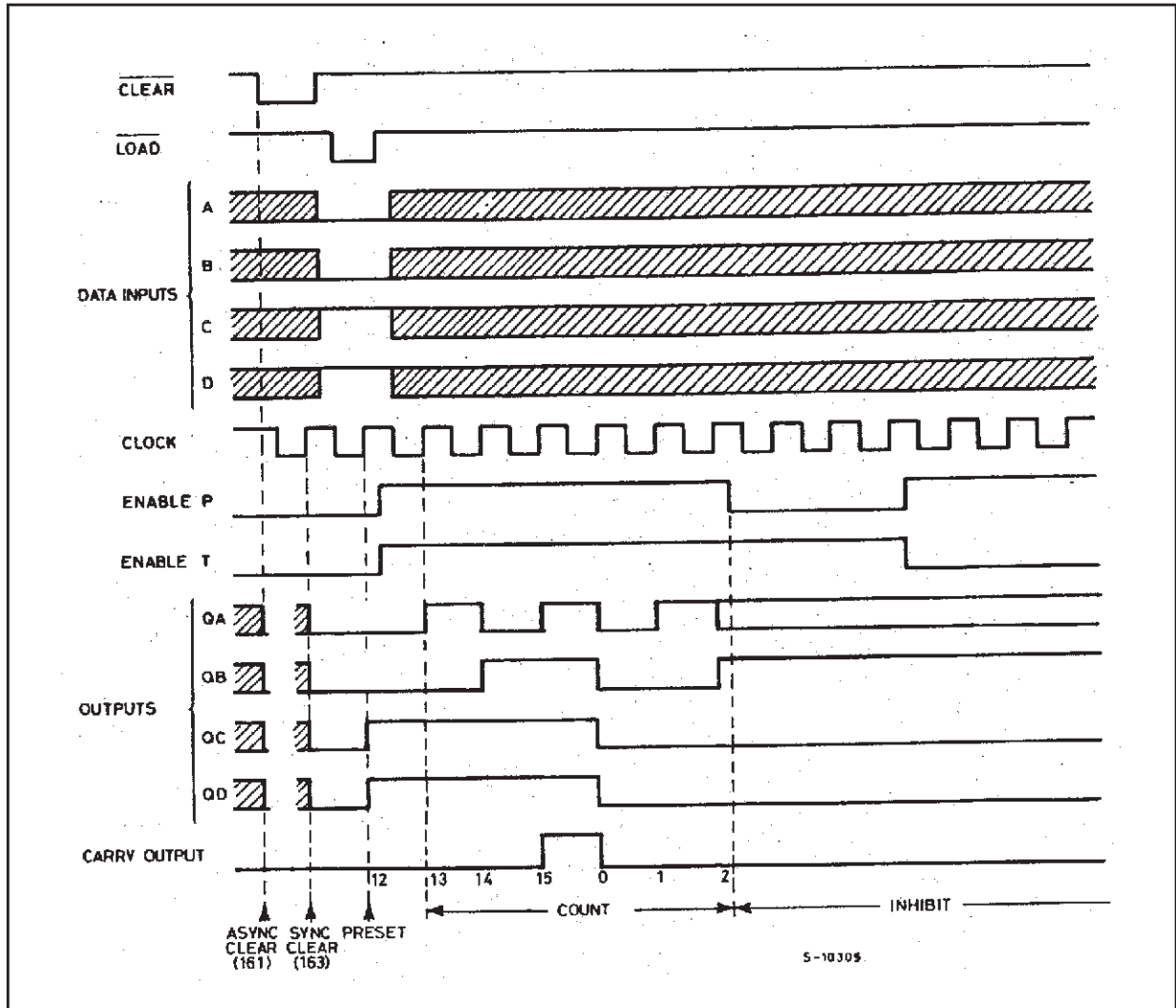
| INPUTS | | | | | OUTPUTS | | | | FUNCTION |
|---------------------------|--------------------------|----|------------------------|-------|-----------|----|----|----|--------------|
| $\overline{\text{CLEAR}}$ | $\overline{\text{LOAD}}$ | PE | $\overline{\text{TE}}$ | CLOCK | QA | QB | QC | QD | |
| L | X | X | X | X | L | L | L | L | RESET TO "0" |
| H | L | X | X | | A | B | C | D | PRESET DATA |
| H | H | X | L | | NO CHANGE | | | | NO COUNT |
| H | H | L | X | | NO CHANGE | | | | NO COUNT |
| H | H | H | H | | COUNT UP | | | | COUNT |
| H | X | X | X | | NO CHANGE | | | | NO COUNT |

NOTE: X: Don't Care
 A, B, C, D: Logic level of data input
 $\text{CARRY OUT} = \overline{\text{TE}} \cdot \text{QA} \cdot \text{QB} \cdot \text{QC} \cdot \text{QD}$

LOGIC DIAGRAMS



TIMING CHART



ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
|-----------------------|-------------------------------|------------------------|-------------|
| V_{CC} | Supply Voltage | -0.5 to +7 | V |
| V_I | DC Input Voltage | -0.5 to $V_{CC} + 0.5$ | V |
| V_O | DC Output Voltage | -0.5 to $V_{CC} + 0.5$ | V |
| I_{IK} | DC Input Diode Current | ± 20 | mA |
| I_{OK} | DC Output Diode Current | ± 20 | mA |
| I_O | DC Output Current | ± 50 | mA |
| I_{CC} or I_{GND} | DC V_{CC} or Ground Current | ± 300 | mA |
| T_{stg} | Storage Temperature | -65 to +150 | $^{\circ}C$ |
| T_L | Lead Temperature (10 sec) | 300 | $^{\circ}C$ |

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these condition is not implied.

RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | Value | Unit |
|----------|---|---------------|-------------|
| V_{CC} | Supply Voltage | 2 to 6 | V |
| V_I | Input Voltage | 0 to V_{CC} | V |
| V_O | Output Voltage | 0 to V_{CC} | V |
| T_{op} | Operating Temperature: | -40 to +85 | $^{\circ}C$ |
| dt/dv | Input Rise and Fall Time $V_{CC} = 3.0, 4.5$ or 5.5 V(note 1) | 8 | ns/V |

1) V_{IN} from 30% to 70% of V_{CC}

DC SPECIFICATIONS

| Symbol | Parameter | Test Conditions | | Value | | | | | Unit | |
|------------------|---------------------------------------|-----------------|--|-------------------------|------|-------|--------------|------|------|------|
| | | | | T _A = 25 °C | | | -40 to 85 °C | | | |
| | | | | V _{CC} (V) | Min. | Typ. | Max. | Min. | | Max. |
| V _{IH} | High Level Input Voltage | 3.0 | V _O = 0.1 V or V _{CC} - 0.1 V | 2.1 | 1.5 | | 2.1 | | V | |
| | | 4.5 | | 3.15 | 2.25 | | 3.15 | | | |
| | | 5.5 | | 3.85 | 2.75 | | 3.85 | | | |
| V _{IL} | Low Level Input Voltage | 3.0 | V _O = 0.1 V or V _{CC} - 0.1 V | | 1.5 | 0.9 | | 0.9 | V | |
| | | 4.5 | | | 2.25 | 1.35 | | 1.35 | | |
| | | 5.5 | | | 2.75 | 1.65 | | 1.65 | | |
| V _{OH} | High Level Output Voltage | 3.0 | V _I ^(*) = V _{IH} or V _{IL} | I _O = -50 μA | 2.9 | 2.99 | | 2.9 | V | |
| | | 4.5 | | I _O = -50 μA | 4.4 | 4.49 | | 4.4 | | |
| | | 5.5 | | I _O = -50 μA | 5.4 | 5.49 | | 5.4 | | |
| | | 3.0 | | I _O = -12 mA | 2.56 | | | 2.46 | | |
| | | 4.5 | | I _O = -24 mA | 3.86 | | | 3.76 | | |
| | | 5.5 | | I _O = -24 mA | 4.86 | | | 4.76 | | |
| V _{OL} | Low Level Output Voltage | 3.0 | V _I ^(*) = V _{IH} or V _{IL} | I _O = 50 μA | | 0.002 | 0.1 | | 0.1 | V |
| | | 4.5 | | I _O = 50 μA | | 0.001 | 0.1 | | 0.1 | |
| | | 5.5 | | I _O = 50 μA | | 0.001 | 0.1 | | 0.1 | |
| | | 3.0 | | I _O = 12 mA | | | 0.36 | | 0.44 | |
| | | 4.5 | | I _O = 24 mA | | | 0.36 | | 0.44 | |
| | | 5.5 | | I _O = 24 mA | | | 0.36 | | 0.44 | |
| I _I | Input Leakage Current | 5.5 | V _I = V _{CC} or GND | | | ±0.1 | | ±1 | μA | |
| I _{CC} | Quiescent Supply Current | 5.5 | V _I = V _{CC} or GND | | | 8 | | 80 | μA | |
| I _{OLD} | Dynamic Output Current (note 1, 2) | 5.5 | V _{OLD} = 1.65 V max | | | | | 75 | mA | |
| I _{OHD} | | | V _{OHD} = 3.85 V min | | | | | -75 | mA | |

1) Maximum test duration 2ms, one output loaded at time

2) Incident wave switching is guaranteed on transmission lines with impedances as low as 50 Ω.

(*) All outputs loaded.

AC ELECTRICAL CHARACTERISTICS ($C_L = 50 \text{ pF}$, $R_L = 500 \Omega$, Input $t_r = t_f = 3 \text{ ns}$)

| Symbol | Parameter | Test Condition | | Value | | | | | Unit | |
|--------------------------------------|---|---------------------|--|------------------------|------------------------|------|------|--------------|------|------|
| | | | | V _{CC} (V) | T _A = 25 °C | | | -40 to 85 °C | | |
| | | | | | Min. | Typ. | Max. | Min. | | Max. |
| t _{PLH} t _{PHL} | Propagation Delay Time CK to Q | 3.3 ^(*) | | 7.0 | 12.0 | | 13.0 | ns | | |
| | | 5.0 ^(**) | | 5.0 | 9.0 | | 10.0 | | | |
| t _{PLH} t _{PHL} | Propagation Delay Time CK to CARRY OUT | 3.3 ^(*) | | 8.5 | 14.0 | | 15.0 | ns | | |
| | | 5.0 ^(**) | | 6.0 | 10.0 | | 11.0 | | | |
| t _{PLH} t _{PHL} | Propagation Delay Time TE to CARRY OUT | 3.3 ^(*) | | 5.5 | 9.5 | | 11.0 | ns | | |
| | | 5.0 ^(**) | | 3.5 | 6.5 | | 7.5 | | | |
| t _{PHL} | Propagation Delay Time CLR to Q | 3.3 ^(*) | | 6.5 | 12.0 | | 13.0 | ns | | |
| | | 5.0 ^(**) | | 5.5 | 9.0 | | 10.0 | | | |
| t _{PHL} | Propagation Delay Time CLR to CARRY OUT | 3.3 ^(*) | | 7.0 | 12.0 | | 13.0 | ns | | |
| | | 5.0 ^(**) | | 5.5 | 9.5 | | 10.0 | | | |
| t _{wL} | CLR pulse Width, LOW (LOAD) | 3.3 ^(*) | | 3.0 | 5.5 | | 7.5 | ns | | |
| | | 5.0 ^(**) | | 2.5 | 4.5 | | 6.0 | | | |
| t _w | CK pulse Width HIGH or LOW | 3.3 ^(*) | | 2.0 | 3.5 | | 4.0 | ns | | |
| | | 5.0 ^(**) | | 2.0 | 3.0 | | 3.5 | | | |
| t _s | Setup Time HIGH or LOW (INPUT to CLOCK) | 3.3 ^(*) | | 4.0 | 13.5 | | 16.0 | ns | | |
| | | 5.0 ^(**) | | 1.5 | 8.5 | | 10.5 | | | |
| t _h | Hold Time HIGH or LOW (INPUT to CLOCK) | 3.3 ^(*) | | -1.0 | -1.0 | | 0.5 | ns | | |
| | | 5.0 ^(**) | | -0.5 | 0.5 | | 1.0 | | | |
| t _s | Setup Time HIGH or LOW (CLEAR to CLOCK) | 3.3 ^(*) | | 3.0 | 11.5 | | 14.0 | ns | | |
| | | 5.0 ^(**) | | 2.0 | 7.5 | | 8.5 | | | |
| t _h | Hold Time HIGH or LOW (CLEAR to CLOCK) | 3.3 ^(*) | | -2.5 | 0 | | 0 | ns | | |
| | | 5.0 ^(**) | | -2.0 | 0.5 | | 1.0 | | | |
| t _s | Setup Time HIGH or LOW (PE or TE to CLOCK) | 3.3 ^(*) | | 3.0 | 6.0 | | 7.0 | ns | | |
| | | 5.0 ^(**) | | 2.0 | 4.5 | | 5.0 | | | |
| t _h | Hold Time HIGH or LOW (PE or TE to CLOCK) | 3.3 ^(*) | | -3.5 | 0 | | 0 | ns | | |
| | | 5.0 ^(**) | | -2.0 | 0 | | 0.5 | | | |
| t _{REM} | Recovery Time CLR to CLOCK | 3.3 ^(*) | | -1.0 | 0 | | 0.5 | ns | | |
| | | 5.0 ^(**) | | -0.5 | 0.5 | | 1.0 | | | |
| f _{MAX} | Maximum Clock Frequency | 3.3 ^(*) | | 70 | 110 | | 60 | MHz | | |
| | | 5.0 ^(**) | | 110 | 165 | | 95 | | | |

(*) Voltage range is 3.3V ± 0.3V

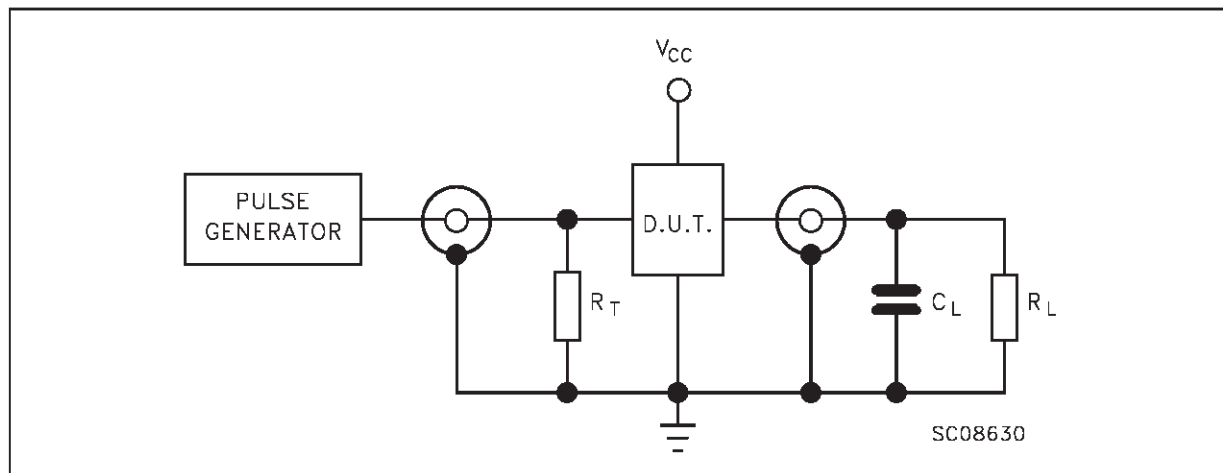
(**) Voltage range is 5V ± 0.5V

CAPACITIVE CHARACTERISTICS

| Symbol | Parameter | Test Conditions | | Value | | | | | Unit | |
|-----------------|---|-----------------|--------------------------|------------------------|------------------------|------|------|--------------|------|------|
| | | | | V _{CC} (V) | T _A = 25 °C | | | -40 to 85 °C | | |
| | | | | | Min. | Typ. | Max. | Min. | | Max. |
| C _{IN} | Input Capacitance | 5.0 | | | 4.5 | | | | pF | |
| C _{PD} | Power Dissipation Capacitance (note 1) | 5.0 | f _{IN} = 10 MHz | | 45 | | | | pF | |

1) C_{PD} is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit). Average operating current can be obtained by the following equation. I_{CC(oper)} = C_{PD} • V_{CC} • f_{IN} + I_{CC/n} (per circuit)

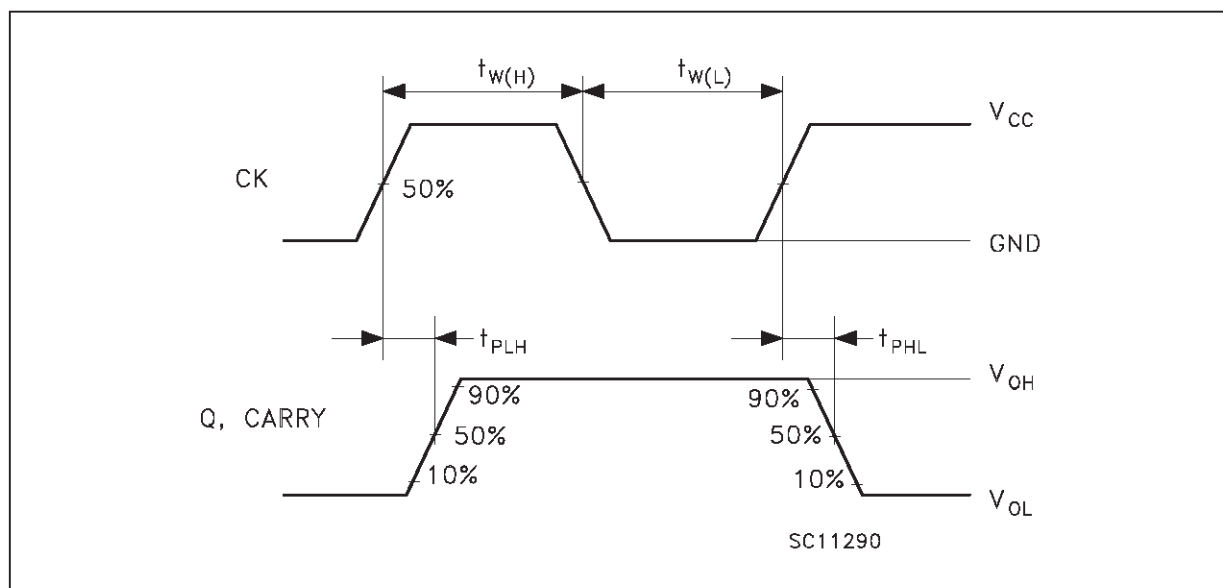
TEST CIRCUIT



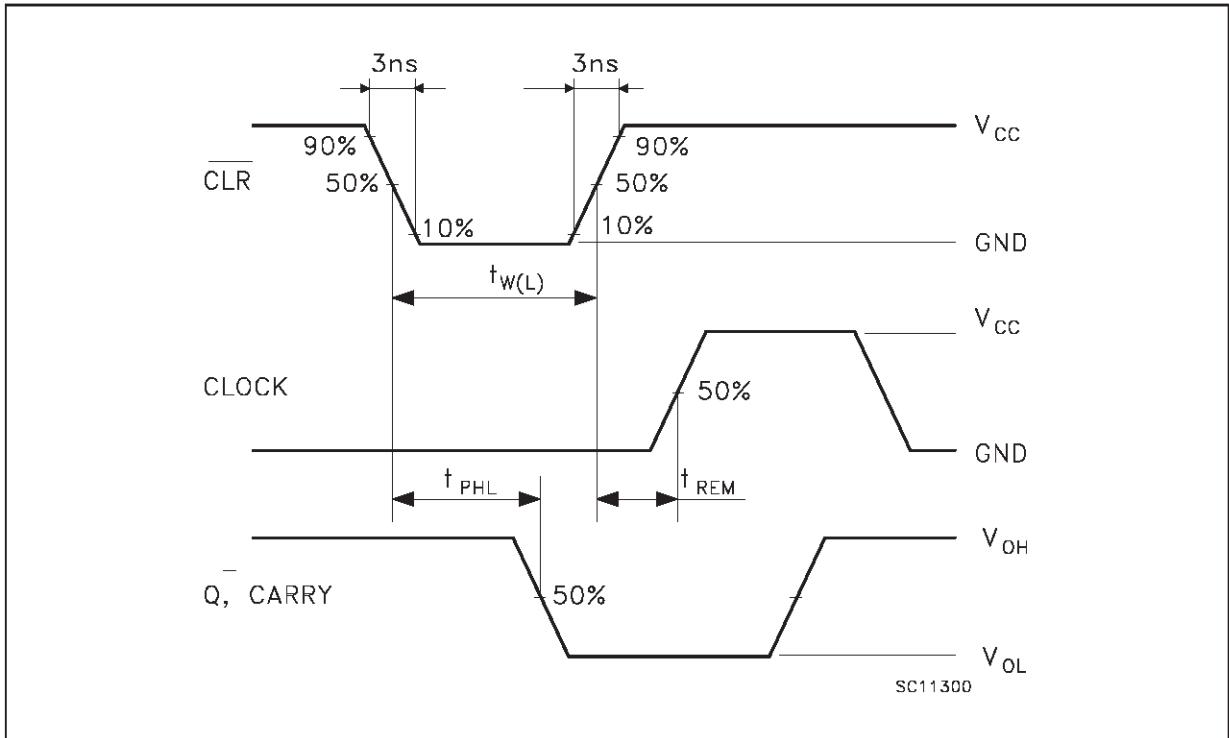
$C_L = 50$ pF or equivalent (includes jig and probe capacitance)

$R_L = R_T = 500\Omega$ or equivalent

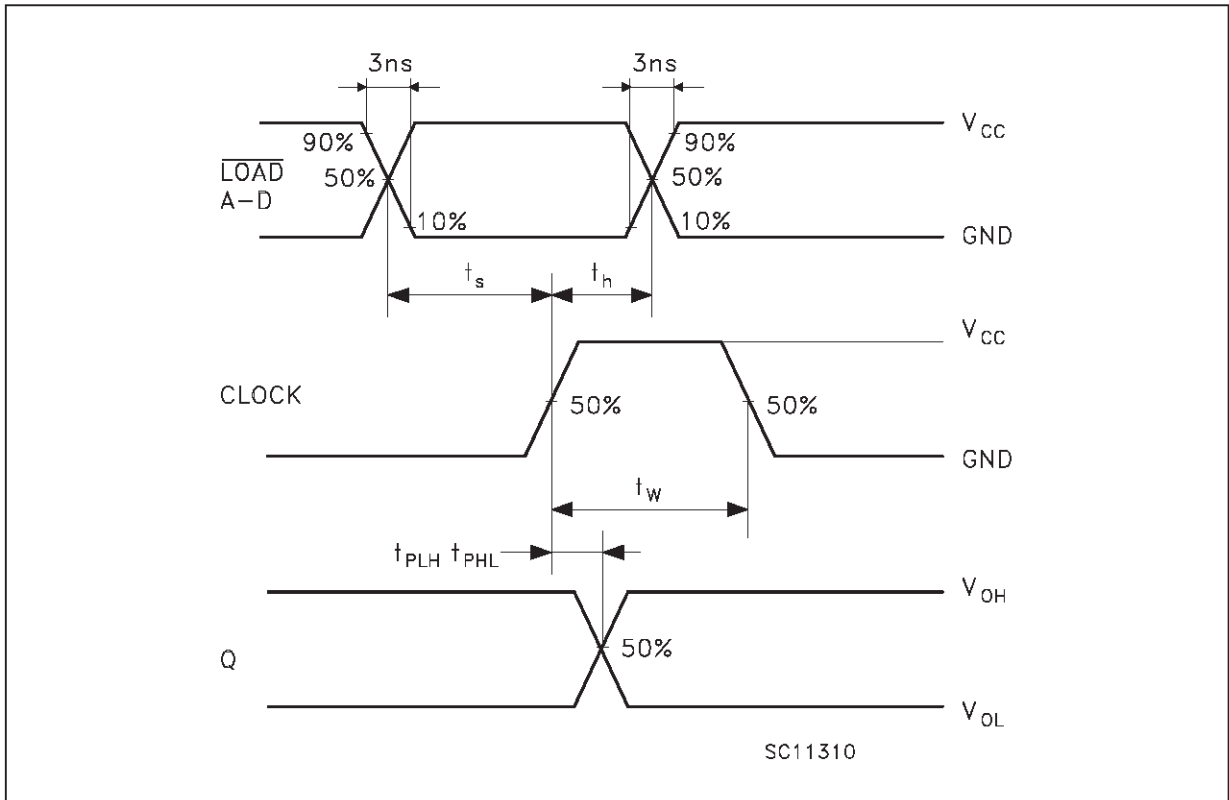
$R_T = Z_{out}$ of pulse generator (typically 50Ω)

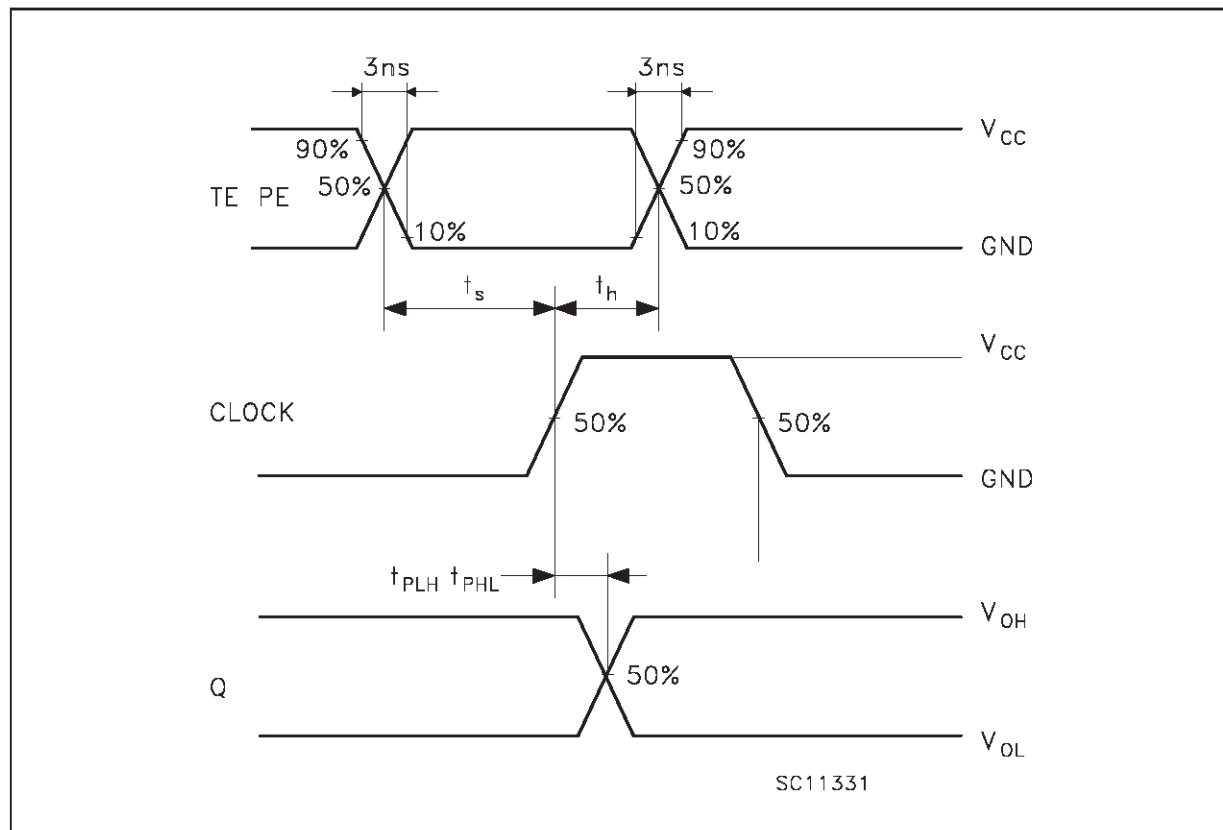
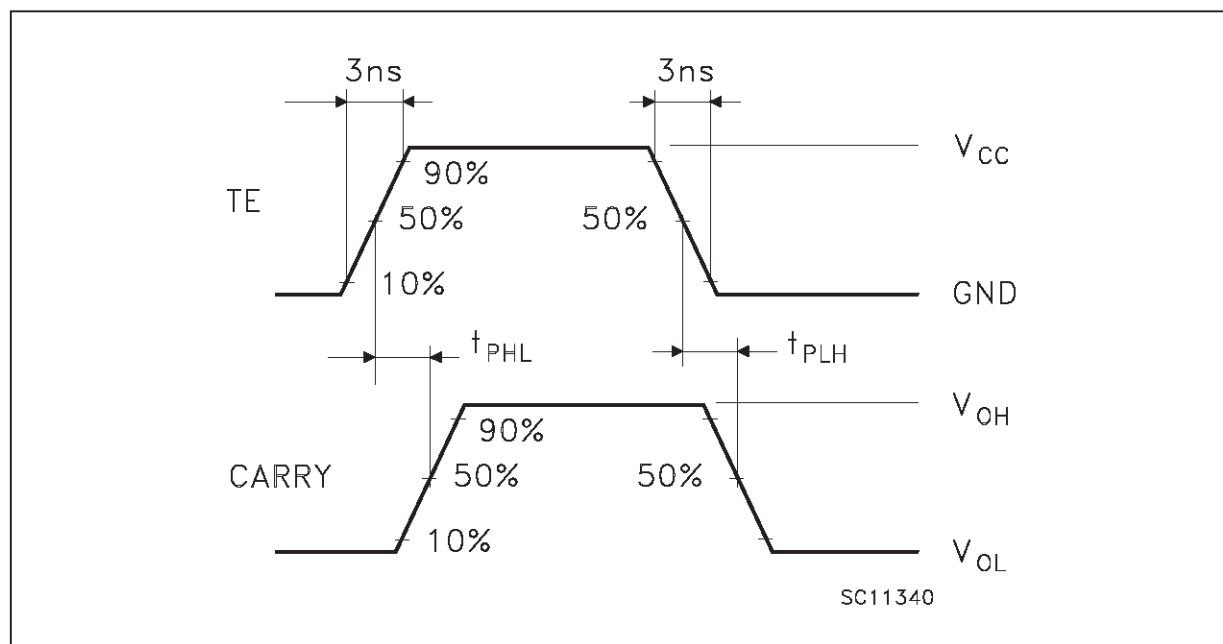
WAVEFORM 1: PROPAGATION DELAYS, COUNT MODE ($f=1$ MHz; 50% duty cycle)

WAVEFORM 2: PROPAGATION DELAYS CLEAR MODE (f=1MHz; 50% duty cycle)



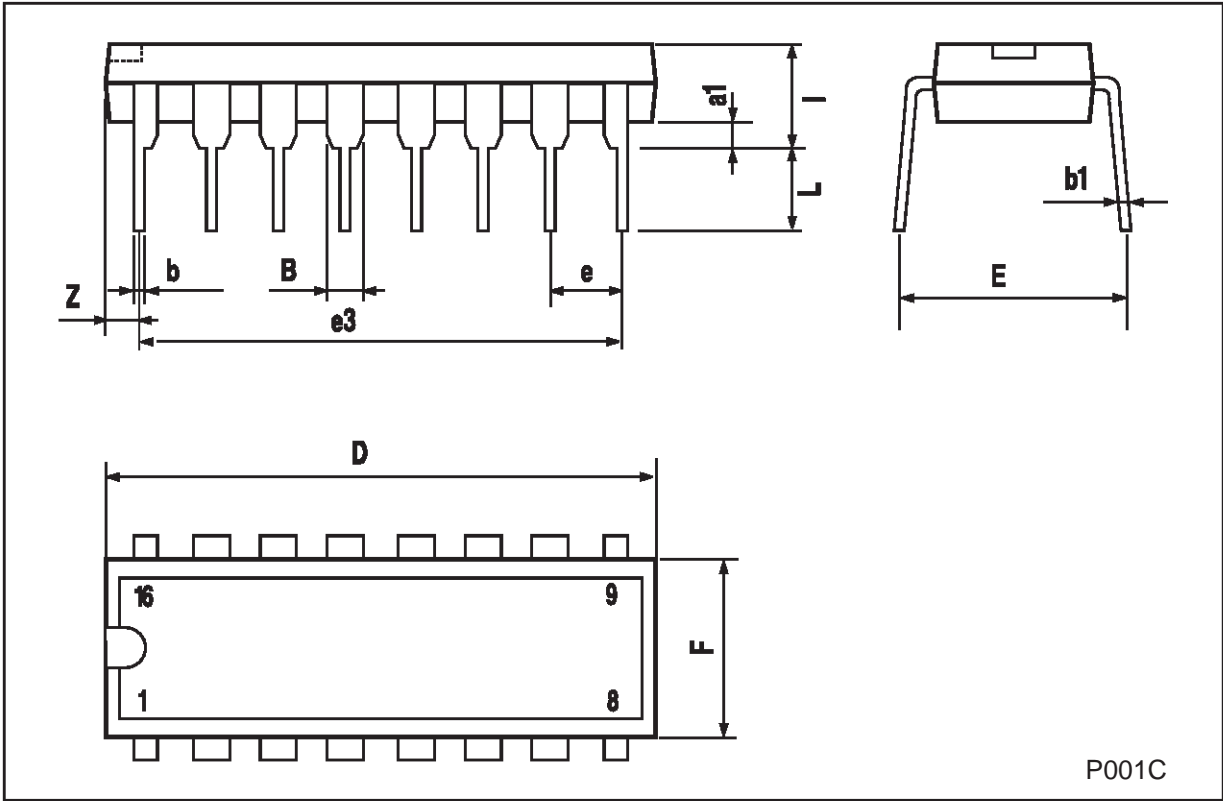
WAVEFORM 3: PROPAGATION DELAYS PRESET MODE (f=1MHz; 50% duty cycle)



WAVEFORM 4: PROPAGATION DELAYS COUNTABLE MODE ($f=1\text{MHz}$; 50% duty cycle)**WAVEFORM 5: PROPAGATION DELAYS CASCADE MODE** ($f=1\text{MHz}$; 50% duty cycle)

Plastic DIP-16 (0.25) MECHANICAL DATA

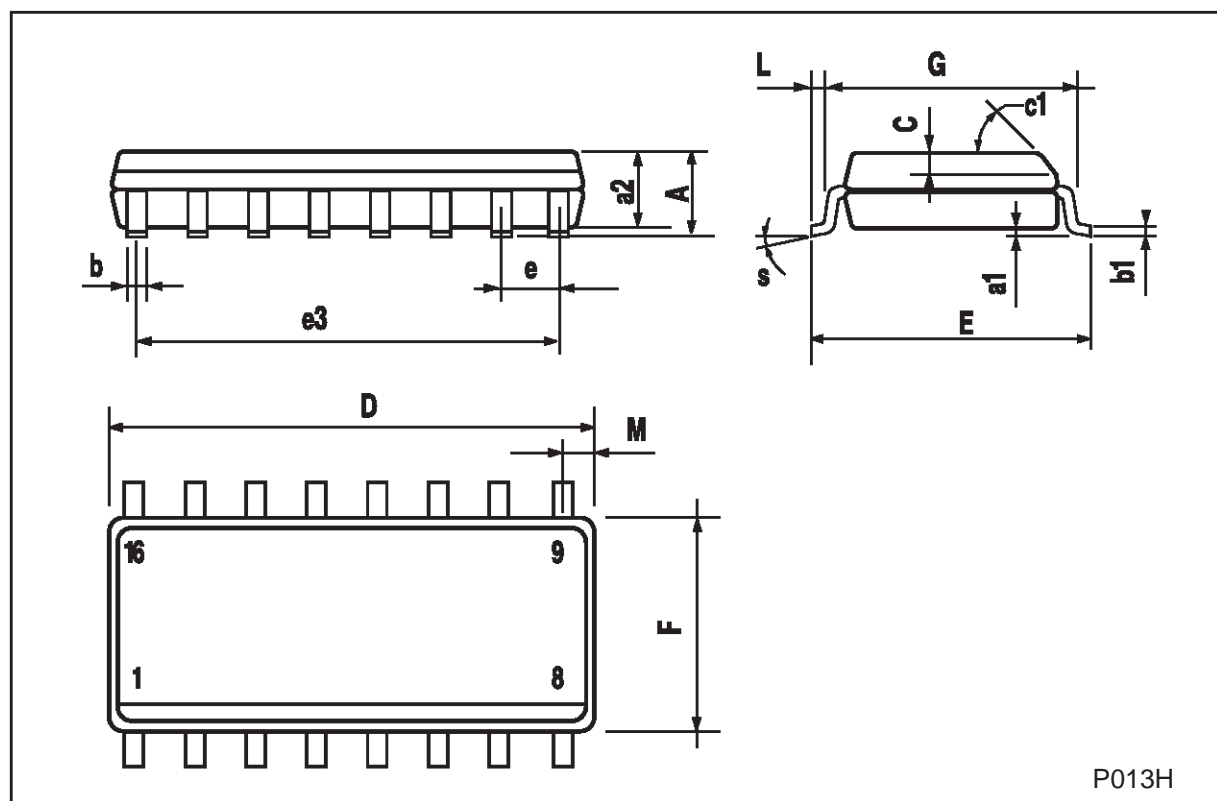
| DIM. | mm | | | inch | | |
|------|------|-------|------|-------|-------|-------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| a1 | 0.51 | | | 0.020 | | |
| B | 0.77 | | 1.65 | 0.030 | | 0.065 |
| b | | 0.5 | | | 0.020 | |
| b1 | | 0.25 | | | 0.010 | |
| D | | | 20 | | | 0.787 |
| E | | 8.5 | | | 0.335 | |
| e | | 2.54 | | | 0.100 | |
| e3 | | 17.78 | | | 0.700 | |
| F | | | 7.1 | | | 0.280 |
| l | | | 5.1 | | | 0.201 |
| L | | 3.3 | | | 0.130 | |
| Z | | | 1.27 | | | 0.050 |



P001C

SO-16 MECHANICAL DATA

| DIM. | mm | | | inch | | |
|------|-----------|------|------|-------|-------|-------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| A | | | 1.75 | | | 0.068 |
| a1 | 0.1 | | 0.2 | 0.004 | | 0.007 |
| a2 | | | 1.65 | | | 0.064 |
| b | 0.35 | | 0.46 | 0.013 | | 0.018 |
| b1 | 0.19 | | 0.25 | 0.007 | | 0.010 |
| C | | 0.5 | | | 0.019 | |
| c1 | 45 (typ.) | | | | | |
| D | 9.8 | | 10 | 0.385 | | 0.393 |
| E | 5.8 | | 6.2 | 0.228 | | 0.244 |
| e | | 1.27 | | | 0.050 | |
| e3 | | 8.89 | | | 0.350 | |
| F | 3.8 | | 4.0 | 0.149 | | 0.157 |
| G | 4.6 | | 5.3 | 0.181 | | 0.208 |
| L | 0.5 | | 1.27 | 0.019 | | 0.050 |
| M | | | 0.62 | | | 0.024 |
| S | 8 (max.) | | | | | |



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